Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/734,834	SZYSZKO, JACEK	
Examiner	Art Unit	_
Ellen C. Tran	2134	

	SEARCHED		
Class	Subclass	Date	Examiner
713	168	6/26/2006	ECT

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH N (INCLUDING SEARC)
	DATE	EXMR
IUSPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES,	6/26/2006	ECT